

<b>Notice of References Cited</b>	Application/Control No. 10/708,851	Applicant(s)/Patent Under Reexamination SHAN ET AL.	
	Examiner Jean W. Désir	Art Unit 2622	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,990,978 A	11-1999	Kim et al.	348/663
*	B	US-6,822,691 B1	11-2004	Kim et al.	348/452
*	C	US-6,400,762 B2	06-2002	Takeshima, Masahiro	375/240.01
*	D	US-7,084,928 B2	08-2006	Tanigawa, Satoru	348/663
*	E	US-6,288,754 B1	09-2001	Ito, Kazuki	348/663
*	F	US-5,589,888 A	12-1996	Iwasaki, Kiyoshi	348/669
*	G	US-5,502,509 A	03-1996	Kurashita et al.	348/669
*	H	US-5,473,389 A	12-1995	Eto et al.	348/669
*	I	US-6,995,804 B2	02-2006	Kwon et al.	348/663
*	J	US-6,674,488 B1	01-2004	Satoh, Yasunori	348/663
*	K	US-6,288,754 B1	09-2001	Ito, Kazuki	348/663
*	L	US-5,311,306 A	05-1994	Tanaka et al.	348/702
*	M	US-5,146,318 A	09-1992	Ishizuka et al.	348/669

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/708,851	Applicant(s)/Patent Under Reexamination SHAN ET AL.	
	Examiner Jean W. Désir	Art Unit 2622	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,585,861 A	12-1996	Taniguchi et al.	348/669
*	B	US-6,774,954 B1	08-2004	Lee, Jooho	348/665
*	C	US-5,589,888 A	12-1996	Iwasaki, Kiyoshi	348/669
*	D	US-5,541,669 A	07-1996	Yamaguchi et al.	348/669
*	E	US-5,003,389	03-1991	Isobe et al.	348/555
*	F	US-2005/0134744 A1	06-2005	SHAN et al.	348/670
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.